## PATENT ABSTRACTS OF JAPAN

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## (54) DEVICE AND METHOD FOR EDITING REPAIR DATA

(57)Abstract:

PURPOSE: To improve the yield of a repair data editing device and reduce man- hours of the device by deleting overlapping data from a repair data file.

CONSTITUTION: At the time of restarting inspections after abnormality eliminating process is completed when abnormality is detected during the course of wafer inspections, the inspections are restarted from, for example, a third wafer when the abnormality eliminating process is completed after a fifth wafer is inspected. In this case, repair data are automatically edited after a seventh wafer is inspected. In other words, overlapping parts exists in an inspection history data file and repair data file. The overlapping parts mean the parts from the wafer number of the third wafer to the end of the data of the fifth wafer and the title of the data. Such overlapping parts are deleted by the automatic edition. Namely, whether or not the repair data are normal is confirmed by comparing the storing order of waver numbers between the two files and one of the

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	22~#3		・ 3女日のタニーが持います。
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	クエハオラ		・ 6を目のソニ・辛子 「衣Eの! ペプテーナ   5を目のデーナ報告
	4-79119		アータタイトル
	りエハゴ3		3歳間のケエル番号・3枚目の(ペプデータ 3歳目のデータ設備
	シャッキチ		「文質のケキル香や、4枚目の5ペプアータ、4枚目のデータ発展
	ウェハ <b>‡</b> 5		「我自のカエル教徒、5本日のリペアデータ、5枚目のデータ教徒
	Q TUTE	<u>.</u>	「我になりまい気に「6世間のフィファー5」6世間のラー5世間
	ウェハギリ	4 1	7枚目のウエルビディを目のフィファーナ 7枚目のテー)配案

overlapping repair data is deleted by obtaining the repair data. Therefore, normal data files which do not contain any overlapping data are obtained.

## LEGAL STATUS

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